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November 2013

FQP13N50

N-Channel QFET® MOSFET

500 V, 12.5 A, 430 $m\Omega$

Description

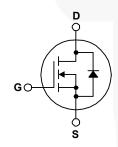
This N-Channel enhancement mode power MOSFET is • 12.5 A, 500 V, $R_{DS(on)}$ = 430 m Ω (Max.) @ V_{GS} = 10 V, produced using Fairchild Semiconductor's proprietary planar stripe and DMOS technology. This advanced MOSFET technology has been especially tailored to reduce on-state

• Low Gate Charge (Typ. 45 nC) resistance, and to provide superior switching performance • Low Crss (Typ. 25 pF) and high avalanche energy strength. These devices are suitable for switched mode power supplies, active power • 100% Avalanche Tested factor correction (PFC), and electronic lamp ballasts.

Features

- $I_D = 6.25 A$





Absolute Maximum Ratings T_C = 25°C unless otherwise noted.

Symbol	Parameter		FQP13N50	Unit	
V _{DSS}	Drain-Source Voltage		500	V	
I _D	Drain Current - Continuous (T _C = 25°C)		12.5	Α	
	- Continuous (T _C = 100°C)		7.9	Α	
I _{DM}	Drain Current - Pulsed	(Note 1)	50	Α	
V _{GSS}	Gate-Source Voltage		± 30	V	
E _{AS}	Single Pulsed Avalanche Energy		810	mJ	
I _{AR}	Avalanche Current	(Note 1)	12.5	Α	
E _{AR}	Repetitive Avalanche Energy (1		17	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		4.5	V/ns	
P_{D}	Power Dissipation (T _C = 25°C)		170	W	
	- Derate above 25°C		1.35	W/°C	
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C	
T _L	Maximum lead temperature for soldering, 1/8" from case for 5 seconds		300	°C	

Thermal Characteristics

Symbol	Parameter	FQP13N50	Unit	
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case, Max.	0.74	°C/W	
$R_{\theta CS}$	Thermal Resistance, Case-to-Sink, Max.	0.5	°C/W	

Package Marking and Ordering Information						
Part Number	Top Mark	Package	Packing Method	Reel Size	Tape Width	Quantity
FQP13N50	FQP13N50	TO-220	Tube	N/A	N/A	50 units
					•	•

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Unit
Off Cha	aracteristics					
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	500			V
ΔBV _{DSS} / ΔT _J	Breakdown Voltage Temperature Coefficient	I _D = 250 μA, Referenced to 25°C		0.48		V/°C
I _{DSS}	Zoro Coto Voltago Droin Current	V _{DS} = 500 V, V _{GS} = 0 V		-	1	μΑ
	Zero Gate Voltage Drain Current	V _{DS} = 400 V, T _C = 125°C		-	10	μΑ
I _{GSSF}	Gate-Body Leakage Current, Forward	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$		-	100	nA
I _{GSSR}	Gate-Body Leakage Current, Reverse	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$		-	-100	nA
On Cha	aracteristics					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	3.0		5.0	V
R _{DS(on)}	Static Drain-Source On-Resistance	V _{GS} =10 V, I _D =6.25 A		0.33	0.43	Ω
9 _{FS}	Forward Transconductance	$V_{DS} = 50 \text{ V}, I_{D} = 6.25 \text{ A}$		10		S
	ic Characteristics					
C _{iss}	Input Capacitance	$V_{DS} = 25 \text{ V}, V_{GS} = 0 \text{ V},$	-	1800	2300	pF
C _{oss}	Output Capacitance	f = 1.0 MHz		245	320	pF
C _{rss}	Reverse Transfer Capacitance			25	35	pF
Switchi	ing Characteristics					
t _{d(on)}	Turn-On Delay Time	V _{DD} = 250 V, I _D = 13.4 A,		40	90	ns
t _r	Turn-On Rise Time	$R_G = 25 \Omega$		140	290	ns
t _{d(off)}	Turn-Off Delay Time	-		100	210	ns
t _f	Turn-Off Fall Time	(Note 4)		85	180	ns
Qg	Total Gate Charge	V _{DS} = 400 V, I _D = 13.4 A,		45	60	nC
Q _{gs}	Gate-Source Charge	V _{GS} = 10 V		11		nC
Q_{gd}	Gate-Drain Charge	(Note 4)	/	22		nC
Drain-S	Source Diode Characteristics a	nd Maximum Ratings				
I _S	Maximum Continuous Drain-Source Diode Forward Current				12.5	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current			-	50	Α
V _{SD}	Drain-Source Diode Forward Voltage	V _{GS} = 0 V, I _S = 12.5 A		-	1.4	V
t _{rr}	Reverse Recovery Time	V _{GS} = 0 V, I _S = 13.4 A,		290		ns
Q _{rr}	Reverse Recovery Charge	dl _F / dt = 100 A/μs		2.6	//	μС

Notes: 1. Repetitive rating : pulse-width limited by maximum junction temperature. 2. L = 9.3 mH, I $_{AS}$ = 12.5 A, V $_{DD}$ = 50 V, R $_{G}$ = 25 Ω , starting T_{J} = 25°C. 3. I $_{SD}$ \leq 13.4 A, di/dt \leq 200 A/ $_{\mu S}$, V $_{DD}$ \leq BV $_{DSS}$, starting T_{J} = 25°C. 4. Essentially independent of operating temperature.

Typical Characteristics

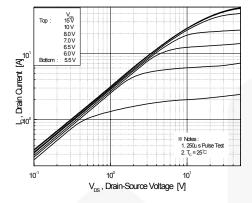


Figure 1. On-Region Characteristics

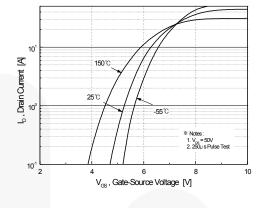


Figure 2. Transfer Characteristics

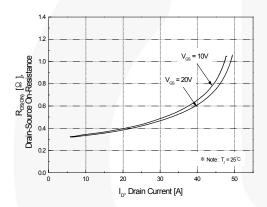


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

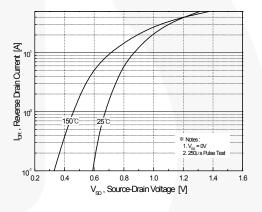


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

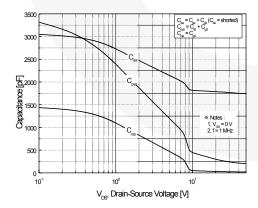


Figure 5. Capacitance Characteristics

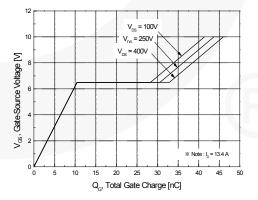


Figure 6. Gate Charge Characteristics

12 **8**1.1

Typical Characteristics (Continued)

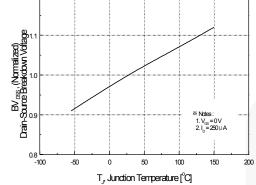


Figure 7. Breakdown Voltage Variation vs. Temperature

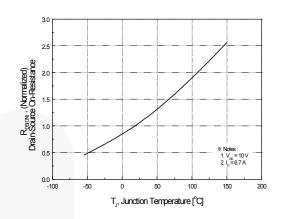


Figure 8. On-Resistance Variation vs. Temperature

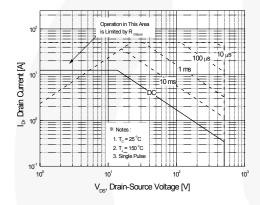


Figure 9. Maximum Safe Operating Area

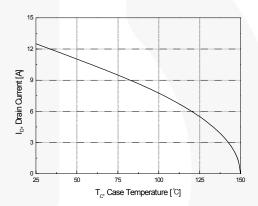


Figure 10. Maximum Drain Current vs. Case Temperature

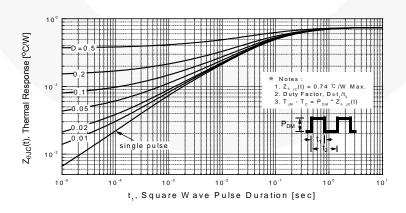


Figure 11. Transient Thermal Response Curve

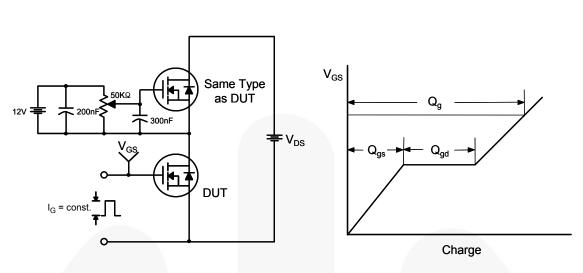


Figure 12. Gate Charge Test Circuit & Waveform

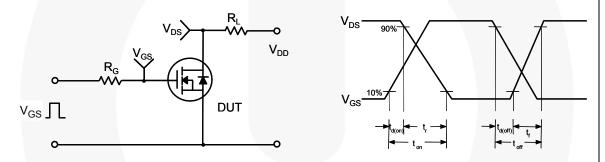


Figure 13. Resistive Switching Test Circuit & Waveforms

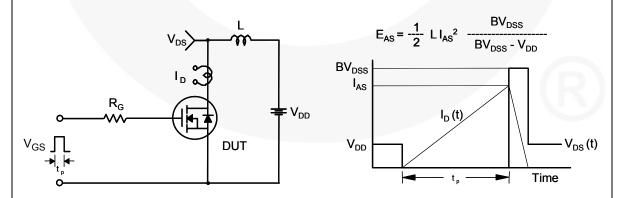
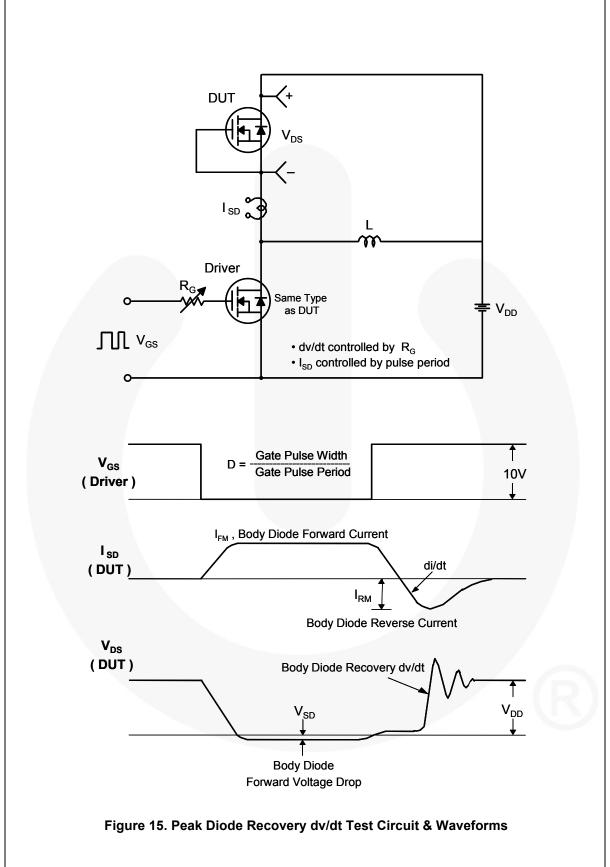


Figure 14. Unclamped Inductive Switching Test Circuit & Waveforms



Mechanical Dimensions

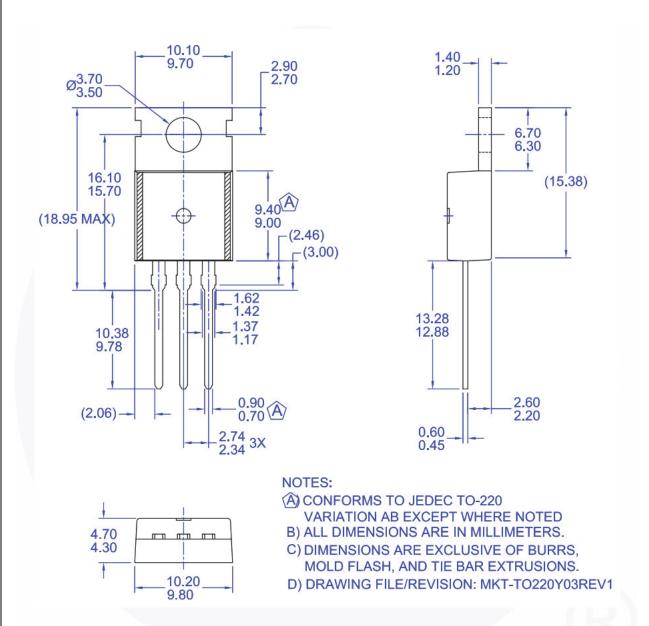


Figure 16. TO220, Molded, 3-Lead, Jedec Variation AB

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Rev. 166